## Applicant(s)/Patent Under Application/Control No. Reexamination 10/735,824 TAKEHARA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1754 Alvin T. Raetzsch

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,887,291	05-2005	Alford et al.	55/302
	В	US-			
	C	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
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## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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## **NON-PATENT DOCUMENTS**

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